

Notice of References Cited	Application/Control No. 10/026,477	Applicant(s)/Patent Under Reexamination YOO ET AL.	
	Examiner Timothy L. Rude	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,106,907	08-2000	Yoshikawa et al.	428/1.1
*	B	US-6,606,137	08-2003	Lee, Hyun Kyu	349/106
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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